

## MOS FIELD EFFECT TRANSISTOR 2SK3484

### SWITCHING N-CHANNEL POWER MOS FET

#### **DESCRIPTION**

The 2SK3484 is N-channel MOS Field Effect Transistor designed for high current switching applications.

#### **FEATURES**

· Low on-state resistance

 $R_{DS(on)1}$  = 125 m $\Omega$  MAX. (VGS = 10 V, ID = 8 A)

 $R_{DS(on)2} = 148 \text{ m}\Omega \text{ MAX.} (V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A})$ 

- Low Ciss: Ciss = 900 pF TYP.
- Built-in gate protection diode
- TO-251/TO-252 package

#### **★ ORDERING INFORMATION**

PART NUMBER	PACKAGE
2SK3484	TO-251 (MP-3)
2SK3484-Z	TO-252 (MP-3Z)

(TO-251)

#### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

	•		
Drain to Source Voltage (Vss = 0 V)	Voss	100	V
Gate to Source Voltage (V <sub>DS</sub> = 0 V)	Vgss	±20	V
Drain Current (DC) (Tc = 25°C)	ID(DC)	±16	Α
Drain Current (pulse) Note1	D(pulse)	±22	Α
Total Power Dissipation (Tc = 25°C)	P <sub>T1</sub>	30	W
Total Power Dissipation (T <sub>A</sub> = 25°C)	P <sub>T2</sub>	1.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C
Single Avalanche Current Note2	las	10	Α
Single Avalanche Energy Note2	Eas	10	mJ



(TO-252)



**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1%

2. Starting T<sub>ch</sub> = 25°C, V<sub>DD</sub> = 50 V, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> = 20  $\rightarrow$  0 V

#### THERMAL RESISTANCE

Channel to Case Thermal Resistance Rth(ch-C) 4.17 °C/W Channel to Ambient Thermal Resistance Rth(ch-A) 125 °C/W

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#### **ELECTRICAL CHARACTERISTICS (TA = 25°C)**

	1	1	1	1	1	1
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	Ipss	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V			10	μΑ
Gate Leakage Current	Igss	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V			±10	μΑ
Gate Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5	2.0	2.5	V
Forward Transfer Admittance Note	y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 8 A	4.7	9.5		S
Drain to Source On-state Resistance Note	RDS(on)1	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 8 A		100	125	mΩ
	R <sub>DS(on)2</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 8 A		110	148	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = 10 V		900		pF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V		110		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		50		pF
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 50 V, I <sub>D</sub> = 8 A		9.0		ns
Rise Time	tr	V <sub>GS</sub> = 10 V		5.0		ns
Turn-off Delay Time	td(off)	R <sub>G</sub> = 0 Ω		30		ns
Fall Time	tf			4.0		ns
Total Gate Charge	QG	V <sub>DD</sub> = 80 V		20		nC
Gate to Source Charge	Qgs	V <sub>GS</sub> = 10 V		3.0		nC
Gate to Drain Charge	Q <sub>GD</sub>	I <sub>D</sub> = 16 A		5.0		nC
Body Diode Forward Voltage Note	V <sub>F(S-D)</sub>	I <sub>F</sub> = 16 A, V <sub>GS</sub> = 0 V		1.0		V
Reverse Recovery Time	trr	I <sub>F</sub> = 16 A, V <sub>GS</sub> = 0 V		60		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ μs		122		nC

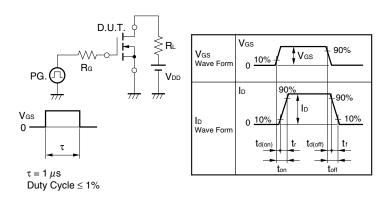
Note Pulsed

#### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**

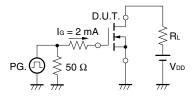
# $V_{GS} = 20 \rightarrow 0 \text{ V}$ $V_{DD}$ $V_{DD}$ $V_{DD}$ $V_{DD}$ $V_{DD}$ $V_{DD}$ $V_{DD}$ $V_{DD}$

Starting Tch

#### TEST CIRCUIT 2 SWITCHING TIME

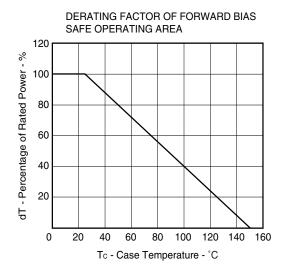


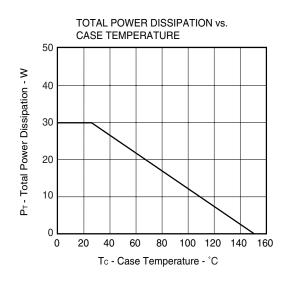
#### **TEST CIRCUIT 3 GATE CHARGE**



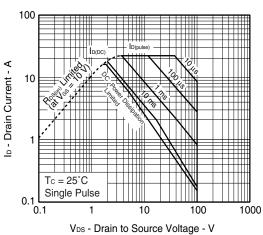


#### TYPICAL CHARACTERISTICS (TA = 25°C)

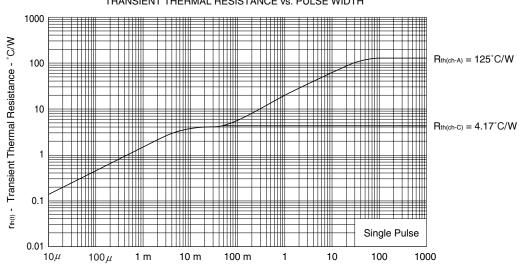




#### FORWARD BIAS SAFE OPERATING AREA



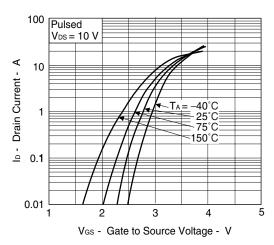
#### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



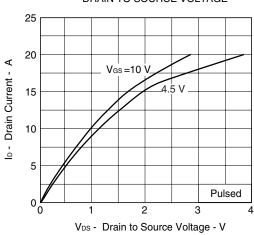
PW - Pulse Width - s

3

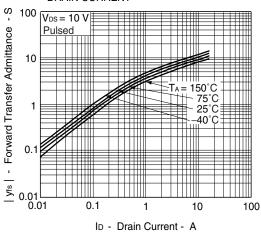
#### FORWARD TRANSFER CHARACTERISTICS



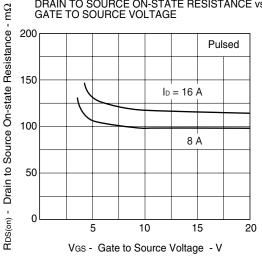




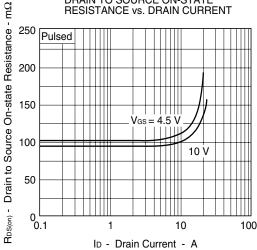
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



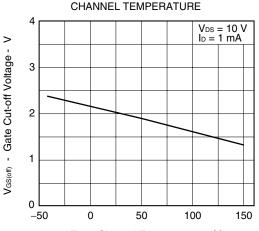
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



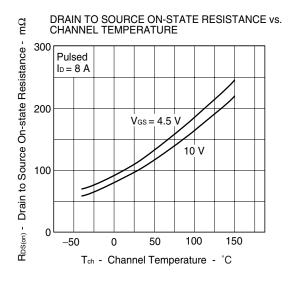
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

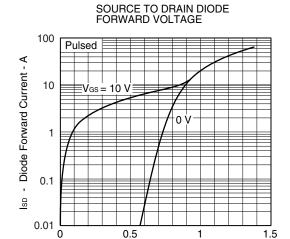


GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

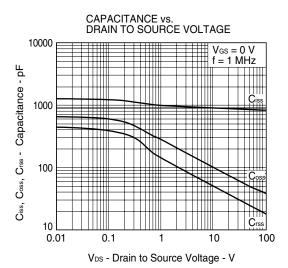


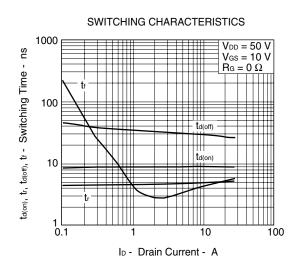


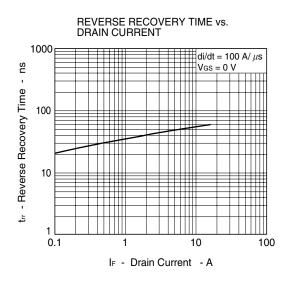


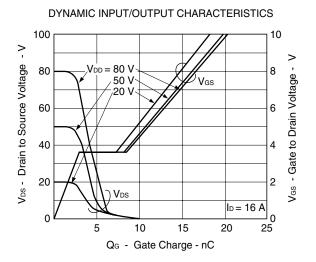


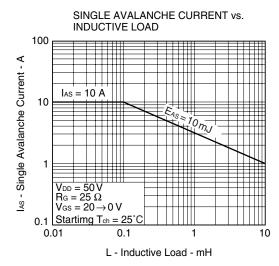
VsD - Source to Drain Voltage - V

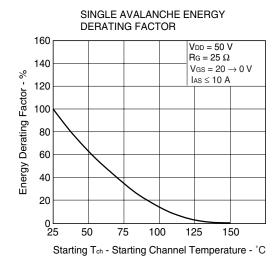






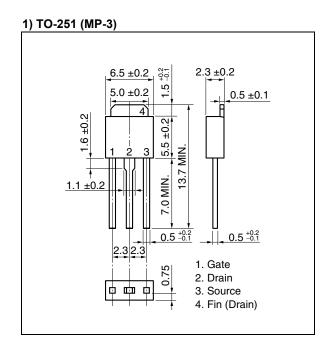


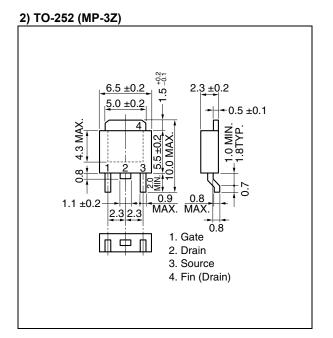




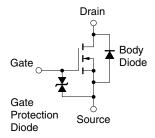


#### **★ PACKAGE DRAWINGS (Unit: mm)**





#### **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD.

When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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